

Snap-off Diodes (See Outline Drawing No. 37)

Type	Power Dissipation 25°C mw	Peak Surge Current 1 μ s amperes	MINIMUM	MAXIMUM	MINIMUM	TYP.	MAX.	TYP.	MAX.
			Breakdown Voltage $I_R=5\mu$ amps I_T Volts	Capacitance $V_R=0V, f=1$ mc C_o pf	Stored Charge Q_T pc/ma	Snap-off time $T_S=2$ nsec. $t_r=20$ ma t_{sp} nsec.		Snap-off time $T_S=2$ nsec. $t_r=100$ ma t_{sp} nsec.	
SSA-550 ⁽²⁾ /554 ⁽³⁾	250	2	12	1.5	20	0.3	0.5		
SSA-551 ⁽²⁾ /555 ⁽³⁾	250	2	8	4.0	20	0.3	0.5		
SSA-552 ⁽²⁾ /556 ⁽³⁾	250	2	12	1.5	1.0			0.2 ⁽¹⁾	0.4
SSA-553 ⁽²⁾ /557 ⁽³⁾	250	2	8	4.0	1.0			0.2 ⁽¹⁾	0.4

NOTES: (1) Limited by resolution time of test equipment. (2) DO-7 package. (3) Micro Silicon Diode—see Specifications 75. 28 for outline dimensions.

Microphoto Diodes*⁽¹⁾ — NPN (See Outline Drawing No. 45)

Type	MAX. ⁽²⁾		MAX. DARK CURRENT	TYPICAL DARK CURRENT	TYPICAL SENSITIVITY ^(3, 4)		TYPICAL PHOTOCURRENT DECAY TIMER
	Bias Volts	P _c mw	at 24 vdc μ a	at 24 vdc μ a	at 250 ft. —c. μ a/ft. —c.	at 1000 ft. —c. μ a/ft. —c.	μ sec.
31F2	40	50	0.1	0.02	0.2	0.8	1
32F2	40	50	0.1	0.02	0.5	1.5	1
33F2	40	50	0.1	0.02	0.9	2.2	1
34F2	40	50	0.1	0.02	1.6	5.0	1

NOTES: *Made in France for General Electric by the Societe Europeenne Des Semiconducteurs (SESCO).

(1) All specs at 25°C unless noted otherwise.

(2) Storage temperature on all types is -65 to +125°C. Operating temperature on all types is -65 to +100°C.

(3) Light source—Tungsten Filament Lamp Operated at a Color Temperature of 2870°K.

(4) Maximum Sensitivity wave length 0.9 to 1.0 microns.